Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
0/525,862	VAN DE BEEK ET AL.	
Examiner	Art Unit	
Ryan C. Jager	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
327	147	5-15-06	res		
327	156	5-15-06	br2		
update	above	10-35-06	RUJ		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Imuted text search (see notes)	21C-00	RES		
tent search	5-16-66	RCJ		
(see notes) test search (see notes)	5-17-06	BK2		
textscarch (see votes)	5-17-06	RUS		
update above	1472/06	RCJ		